

Progress in Pattern Recognition, Image Analysis and Applications

10th Iberoamerican Congress on Pattern Recognition, CIARP 2005, Havana, Cuba, November 15-18, 2005, Proceedings

CIARP 2005 (10th Iberoamerican Congress on Pattern Recognition, X CIARP) is the 10th event in the series of pioneer congresses on pattern recognition in the Iberoamerican community, which takes place in La Habana, Cuba. As in previous years, X CIARP brought together international scientists to promote and disseminate ongoing research and mathematical methods for pattern recognition, image analysis, and applications in such diverse areas as computer vision, robotics, industry, health, entertainment, space exploration, telecommunications, data mining, document analysis, and natural language processing and recognition, to name a few. Moreover, X CIARP was a forum for scientific research, experience exchange, share of new knowledge and increase in cooperation between research groups in pattern recognition, computer vision and related areas. The 10th Iberoamerican Congress on Pattern Recognition was organized by the Cuban Association for Pattern Recognition (ACRP) and sponsored by the Institute of Cybernetics, Mathematics and Physics (ICIMAF), the Advanced Technologies Application Center (CENATAV), the University of Oriente (UO), the Polytechnic Institute "José A Echevarría" (ISPJAE), the Central University of Las Villas (UCLV), the Ciego de Avila University (UNICA), as well as the Center of Technologies Research on Information and Systems (CITIS-UAEH) in Mexico. The conference was also co-sponsored by the Portuguese Association for Pattern Recognition (APRP), the Spanish Association for Pattern Recognition and Image Analysis (AERFAI), the Special Interest Group of the Brazilian Computer Society (SIGPR-SBC), and the Mexican Association for Computer Vision, Neurocomputing and Robotics (MACVNR). X CIARP was endorsed by the International Association for Pattern Recognition (IAPR).

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